

Up to 4 GHz Linear Power Silicon Bipolar Transistor

Technical Data

AT-64023

Features

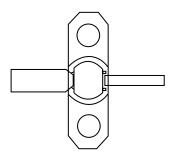
- High Output Power: $27.5 \, \mathrm{dBm} \, \mathrm{Typical} \, \mathrm{P}_{1 \, \mathrm{dB}} \, \mathrm{at} \, 2.0 \, \mathrm{GHz}$ $26.5 \, \mathrm{dBm} \, \mathrm{Typical} \, \mathrm{P}_{1 \, \mathrm{dB}} \, \mathrm{at} \, 4.0 \, \mathrm{GHz}$
- High Gain at 1 dB Compression: $12.5\,\mathrm{dB\,Typical\,G_{1\,dB}} \\ at\,2.0\,\mathrm{GHz} \\ 9.5\,\mathrm{dB\,Typical\,G_{1\,dB}} \\ at\,4.0\,\mathrm{GHz}$
- 35% Total Efficiency
- Emitter Ballast Resistors
- Hermetic, Metal/Beryllia Stripline Package

Description

The AT-64023 is a high performance NPN silicon bipolar transistor housed in a hermetic BeO flange package for good thermal characteristics. This device is designed for use in medium power, wide band amplifier and oscillator applications operating over VHF, UHF and microwave frequencies.

Excellent device uniformity, performance and reliability are produced by the use of ionimplantation, self-alignment techniques, and gold metallization in the fabrication of these devices. The use of ion-implanted ballast resistors ensures uniform current distribution through the multiple emitter fingers.

230 mil BeO Package



4-183 5965-8916E

AT-64023 Absolute Maximum Ratings

| 0_0_0 | TIDDOTAGE MIGHINITATIN IGA | 011150 | | | |
|--------------------|----------------------------|--------|------------------------------------|--|--|
| Symbol | Parameter | Units | Absolute Maximum ^[1] | | |
| V_{EBO} | Emitter-Base Voltage | V | 2.2 | | |
| V_{CBO} | Collector-Base Voltage | V | 40 | | |
| V_{CEO} | Collector-Emitter Voltage | V | 20 | | |
| I_{C} | Collector Current | mA | 200 | | |
| P_{T} | Power Dissipation [2,3] | W | 3 | | |
| $T_{\rm j}$ | Junction Temperature | °C | 200 | | |
| T_{STG} | Storage Temperature | °C | -65 to 200 | | |

| Thermal Resistance [2,4]: | |
|---|--|
| $\theta_{\rm jc} = 40^{\circ} { m C/W}$ | |

Notes:

- 1. Permanent damage may occur if any of these limits are exceeded.
- 2. $T_{CASE} = 25$ °C.
- 3. Derate at 25 mW/°C for $T_C > 80$ °C.
- 4. The small spot size of this technique results in a higher, though more accurate determination of θ_{jc} than do alternate methods. See MEASUREMENTS section "Thermal Resistance" for more information.

Electrical Specifications, $T_A = 25^{\circ}C$

| Symbol | Parameters and Test Conditions | Units | Min. | Тур. | Max. | |
|---------------------|--|--|------|------|--------------|-----|
| $ S_{21E} ^2$ | Insertion Power Gain; $V_{CE} = 16 V$, $I_{C} = 110 mA$ | $f = 2.0 \mathrm{GHz}$ $f = 4.0 \mathrm{GHz}$ | dB | | 6.5 2.0 | |
| P _{1 dB} | Power Output @ 1 dB Gain Compression $V_{CE} = 16V, I_C = 110\text{mA}$ | $f = 2.0 \mathrm{GHz}$ $f = 4.0 \mathrm{GHz}$ | dBm | 25.5 | 27.5 26.5 | |
| $G_{1 dB}$ | 1 dB Compressed Gain; $V_{CE} = 16 V$, $I_C = 110 mA$ | $f = 2.0 \mathrm{GHz}$ $f = 4.0 \mathrm{GHz}$ | dB | 7.0 | 12.5 9.5 | |
| η_{T} | Total Efficiency $^{[1]}$ at 1 dB Compression: $V_{CE} = 16V, I_C = 110mA$ | $f = 4.0 \mathrm{GHz}$ | % | | 35.0 | |
| h_{FE} | Forward Current Transfer Ratio; $V_{CE} = 8 \text{ V}$, $I_{C} = 110 \text{ r}$ | nA | _ | 20 | 50 | 200 |
| I_{CBO} | Collector Cutoff Current; $V_{CB} = 16 V$ | | μA | | | 100 |
| I_{EBO} | Emitter Cutoff Current; $V_{EB} = 1 \text{ V}$ | | μА | | | 5.0 |

Note:

^{1.} $\eta_T = (RF Output Power)/(RF Input Power + V_{CE}I_C)$.

AT-64023 Typical Performance, $T_A = 25^{\circ}C$

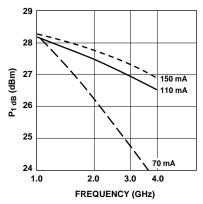


Figure 1. Power Output @ 1 dB Gain Compression vs. Frequency and Collector Current. V_{CE} = 16 V.

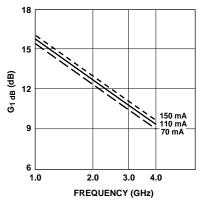


Figure 2. 1 dB Compressed Gain vs. Frequency and Collector Current. V_{CE} = 16 V.

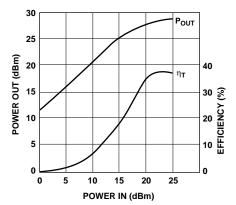


Figure 3. Output Power and Efficiency vs. Input Power. $V_{CE} = 16\ V,\ I_C = 110mA,\ f = 4.0\ GHz.$

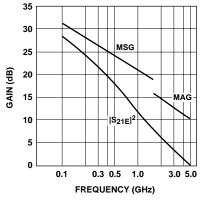


Figure 4. Insertion Power Gain, Maximum Available Gain and Maximum Stable Gain vs. Frequency. $V_{CE}=16\ V,\ I_C=110\ mA.$

$\textbf{Typical Scattering Parameters,} \ \text{Common Emitter,} \ Z_{O} = 50 \ \Omega, T_{A} = 25 \ \text{C}, V_{CE} = 16 \ \text{V,I}_{C} = 110 \ \text{mA}$

| ~ _ | | ~ | , | | | , | , | 022 | , 0 | |
|-------|-----------------|------|------|----------|-------------|-------------------|------|-------------------|------|------|
| Freq. | S ₁₁ | | | S_{21} | | $\mathbf{S_{12}}$ | | \mathbf{S}_{22} | | |
| GHz | Mag. | Ang. | dB | Mag. | Ang. | dB | Mag. | Ang. | Mag. | Ang. |
| 0.1 | .54 | -124 | 28.2 | 25.71 | 135 | -33.3 | .022 | 42 | .72 | -51 |
| 0.5 | .80 | -178 | 17.6 | 7.57 | 78 | -29.5 | .034 | 18 | .33 | -119 |
| 1.0 | .80 | 162 | 11.9 | 3.92 | 47 | -28.6 | .037 | 10 | .33 | -142 |
| 1.5 | .80 | 147 | 8.6 | 2.70 | 21 | -27.9 | .040 | 12 | .40 | -156 |
| 2.0 | .78 | 133 | 6.3 | 2.07 | -4 | -27.6 | .042 | 1 | .48 | -169 |
| 2.5 | .77 | 127 | 5.1 | 1.80 | - 24 | -25.5 | .053 | - 5 | .58 | -178 |
| 3.0 | .73 | 116 | 3.8 | 1.56 | - 51 | -25.0 | .056 | -20 | .67 | 170 |
| 3.5 | .66 | 106 | 2.9 | 1.40 | -79 | -25.8 | .051 | -28 | .78 | 156 |
| 4.0 | .60 | 99 | 2.2 | 1.28 | -109 | -27.2 | .044 | -4 9 | .86 | 142 |
| 4.5 | .55 | 98 | 1.4 | 1.18 | -141 | -31.2 | .028 | -70 | .93 | 127 |
| 5.0 | .54 | 99 | 0.6 | 1.07 | -175 | -40.9 | .009 | -144 | .93 | 112 |

A model for this device is available in the DEVICE MODELS section.

S-parameters at other bias conditions are available on the Hewlett-Packard Design Pak disk.

230 mil BeO Package Dimensions

